

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/532,343	LEE, MIN-HWA	
Examiner	Art Unit	
Saved T. Zewari	2617	

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Class	Subclass	Date	Examiner
455	575.19	10/4/2006	STZ
455	90.2	10/4/2006	STZ
455	550.1	10/4/2006	STZ
455	556.1	10/4/2006	STZ
455	572	10/4/2006	STZ
455	574	10/5/2006	STZ
455	127.1	10/5/2006	STZ
455	127.5	10/5/2006	STZ
455	343.5	10/5/2006	STZ

INT	TERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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